

U.S. PATENT DOCUMENTS

Examiner	Document No.	Date	Name	Class	Sub	
BT	3 6 6 0 1 3 6	5/72	Guilbault et al.	117	17	
	4 1 6 0 9 2 6	7/79	Cope et al.	310	215	
	5 3 2 8 9 7 5	7/94	Hanson et al.	528	29	
	5 4 0 1 5 3 1	3/95	Faraoni et al.	427	12.7	
	5 4 7 0 6 1 5	11/95	Sbalchiero et al.	427	459	
	5 4 7 4 7 9 9	12/95	Thigpen et al.	427	104	
	5 6 9 3 3 7 1	12/97	Rodzewich et al.	427	421	
	5 7 1 6 6 6 3	2/98	Capote et al.	427	96	
	5 8 0 1 2 1 7	9/98	Rodzewich et al.	523	409	
	5 9 0 8 5 2 2	6/99	Lofstrom et al.	156	94	
	5 9 5 3 8 3 2	9/99	Rosynsky et al.	34	403	
BT	5 9 8 5 0 4 8	11/99	Wahlert et al.	148	272	

FOREIGN PATENT DOCUMENTS

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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

Examiner:	B. Talbot	Date Considered:	6/30/03

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